

IGBT/SiC Diode Co-pack

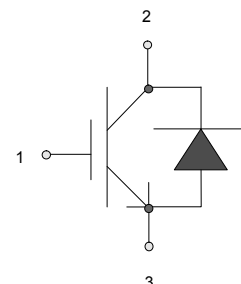
V_{CES}	=	1200 V
I_{CM}	=	100 A
$V_{CE(SAT)}$	=	1.9 V

Features

- Optimal Punch Through (OPT) technology
- SiC freewheeling diode
- Positive temperature coefficient for easy paralleling
- Extremely fast switching speeds
- Temperature independent switching behavior of SiC rectifier
- Best RBSOA/SCSOA capability in the industry
- High junction temperature
- Industry standard packaging

Package

- RoHS Compliant



SOT – 227

Advantages

- Industry's highest switching speeds
- High temperature operation
- Improved circuit efficiency
- Low switching losses

Applications

- Solar Inverters
- Aerospace Actuators
- Server Power Supplies
- Resonant Inverters > 100 kHz
- Inductive Heating
- Electronic Welders

Maximum Ratings at $T_j = 175\text{ }^{\circ}\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
IGBT				
Collector-Emitter Voltage	V_{CES}		1200	V
DC-Collector Current	I_C	$T_C \leq 130\text{ }^{\circ}\text{C}$	100	A
Peak Collector Current	I_{CM}	Limited by T_{vjmax}	200	A
Gate Emitter Peak Voltage	V_{GES}		± 20	V
IGBT Short Circuit SOA	t_{psc}	$V_{CC} = 900\text{ V}$, $V_{CEM} \leq 1200\text{ V}$ $V_{GE} \leq 15\text{ V}$, $T_{vj} \leq 125\text{ }^{\circ}\text{C}$	10	μs
Operating Temperature	T_{vj}		-40 to +175	$^{\circ}\text{C}$
Storage Temperature	T_{stg}		-40 to +175	$^{\circ}\text{C}$
Isolation Voltage	V_{ISOL}	$I_{SOL} < 1\text{ mA}$, 50/60 Hz, $t = 1\text{ s}$	3000	V

Free-wheeling Silicon Carbide diode

DC-Forward Current	I_F	$T_C \leq 130\text{ }^{\circ}\text{C}$	100	A
Non Repetitive Peak Forward Current	I_{FM}	$T_C = 25\text{ }^{\circ}\text{C}$, $t_p = 10\text{ }\mu\text{s}$	tbd	A
Surge Non Repetitive Forward Current	$I_{F,SM}$	$t_p = 10\text{ ms}$, half sine, $T_C = 25\text{ }^{\circ}\text{C}$	tbd	A

Thermal Characteristics

Thermal resistance, junction - case	R_{thJC}	IGBT	0.08	$^{\circ}\text{C/W}$
Thermal resistance, junction - case	R_{thJC}	SiC Diode	0.53	$^{\circ}\text{C/W}$

Mechanical Properties

		Values		
		min.	typ.	max.
Mounting Torque	M_d		1.5	Nm
Terminal Connection Torque		1.3		1.5 Nm
Weight			29	g
Case Color			Black	
Dimensions			38 x 25.4 x 12	mm

Electrical Characteristics at $T_j = 175^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
IGBT						
Gate Threshold Voltage	$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 4\text{ mA}, T_J = 25\text{ }^{\circ}\text{C}$	5	6.2	7	V
Collector-Emitter Leakage Current	$I_{CES,25}$	$V_{GE} = 0\text{ V}, V_{CE} = V_{CES}, T_J = 25\text{ }^{\circ}\text{C}$		0.10	1	mA
	$I_{CES,175}$	$V_{GE} = 0\text{ V}, V_{CE} = V_{CES}, T_J = 175\text{ }^{\circ}\text{C}$		3.15		mA
Gate-Leakage Current	I_{GES}	$V_{CE} = 0\text{ V}, V_{GE} = 20\text{ V}, T_J = 175\text{ }^{\circ}\text{C}$	-400		400	nA
Collector-Emitter Threshold Voltage	$V_{CE(TO)}$	$T_J = 25\text{ }^{\circ}\text{C}$		1.1		V
Collector-Emitter Slope Resistance	$R_{CE,25}$	$V_{GE} = 15\text{ V}, T_J = 25\text{ }^{\circ}\text{C}$		7.9		mΩ
	$R_{CE,175}$	$V_{GE} = 15\text{ V}, T_J = 175\text{ }^{\circ}\text{C}$		11.4		mΩ
Collector-Emitter Saturation Voltage	$V_{CE(SAT)}$	$I_C = 100\text{ A}, V_{GE} = 15\text{ V}, T_J = 25\text{ }^{\circ}\text{C} (175\text{ }^{\circ}\text{C})$		1.9 (2.2)		V
Input Capacitance	C_{ies}	$V_{GE} = 0\text{ V}, V_{CE} = 25\text{ V}, f = 1\text{ MHz}, T_J = 150\text{ }^{\circ}\text{C}$		8.55		nF
Output Capacitance	C_{oes}			1.39		nF
Reverse Transfer Capacitance	C_{res}			0.25		nF
Internal Gate Resistance	R_{Gint}			2		Ω
Gate Charge	Q_G	$V_{CC} = 750\text{ V}, I_C = 100\text{ A}, V_{GE} = -8..15\text{ V}, T_J = 25\text{ }^{\circ}\text{C} (125\text{ }^{\circ}\text{C})$		900 (900)		nC
Module Lead Resistance	R_{mod}	$T_c = 25\text{ }^{\circ}\text{C} (175\text{ }^{\circ}\text{C})$		tbd		mΩ
Reverse Bias Safe Operating Area	RBSOA	$T_J = 175\text{ }^{\circ}\text{C}, R_g = 56\Omega, V_{CC} = 1200\text{ V}, V_{GE} = 15\text{ V}$		150		A
Short Circuit Current	I_{sc}	$T_J = 175\text{ }^{\circ}\text{C}, R_g = 56\Omega, V_{CC} = 900\text{ V}, V_{GE} = \pm 15\text{ V}$		470		A
Short Circuit Duration	t_{sc}				10	μs
Rise Time	t_r	$V_{CC} = 800\text{ V}, I_C = 100\text{ A}, R_{gon} = R_{goff} = 10\text{ }^{\circ}\Omega, V_{GE(on)} = 15\text{ V}, V_{GE(off)} = -8\text{ V}, L_S = 0.8\text{ }^{\circ}\mu\text{H}, T_J = 25\text{ }^{\circ}\text{C}$		254		ns
Fall Time	t_f			153		ns
Turn On Delay Time	$t_{d(on)}$			244		ns
Turn Off Delay Time	$t_{d(off)}$			488		ns
Turn-On Energy Loss Per Pulse	E_{on}			14.2		mJ
Turn-Off Energy Loss Per Pulse	E_{off}			15.7		mJ
Rise Time	t_r	$V_{CC} = 800\text{ V}, I_C = 100\text{ A}, R_{gon} = R_{goff} = 10\text{ }^{\circ}\Omega, V_{GE(on)} = 15\text{ V}, V_{GE(off)} = -8\text{ V}, L_S = 0.8\text{ }^{\circ}\mu\text{H}, T_J = 175\text{ }^{\circ}\text{C}$		211		ns
Fall Time	t_f			172		ns
Turn On Delay Time	$t_{d(on)}$			240		ns
Turn Off Delay Time	$t_{d(off)}$			636		ns
Turn-On Energy Loss Per Pulse	E_{on}			11.1		mJ
Turn-Off Energy Loss Per Pulse	E_{off}			21.8		mJ

Free-wheeling Silicon Carbide Diode

Forward Voltage	V_F	$I_F = 100\text{ A}, V_{GE} = 0\text{ V}, T_j = 25^\circ\text{C} (175^\circ\text{C})$	2.08 (3.5)		V
Threshold Voltage at Diode	$V_{D(TO)}$	$T_j = 25^\circ\text{C}$	0.8		V
Peak Reverse Recovery Current	I_{rrm}	$I_F = 100\text{ A}, V_{GE} = 0\text{ V}, V_R = 800\text{ V}, -di_F/dt = 625\text{ A/μs}, T_j = 175^\circ\text{C}$	10		A
Reverse Recovery Time	t_{rr}		100		ns
Rise Time	t_r	$V_{CC} = 800\text{ V}, I_C = 100\text{ A}, R_{gon} = R_{goff} = 10\Omega, V_{GE(on)} = 15\text{ V}, V_{GE(off)} = -8\text{ V}, L_S = 0.8\text{ μH}, T_j = 25^\circ\text{C}$	148		ns
Fall Time	t_f		336		ns
Turn-On Energy Loss Per Pulse	E_{on}		218		μJ
Turn-Off Energy Loss Per Pulse	E_{off}		113		μJ
Reverse Recovery Charge	Q_{rr}		730		nC
Rise Time	t_r	$V_{CC} = 800\text{ V}, I_C = 100\text{ A}, R_{gon} = R_{goff} = 10\Omega, V_{GE(on)} = 15\text{ V}, V_{GE(off)} = -8\text{ V}, L_S = 0.8\text{ μH}, T_j = 175^\circ\text{C}$	178		ns
Fall Time	t_f		268		ns
Turn-On Energy Loss Per Pulse	E_{on}		23		μJ
Turn-Off Energy Loss Per Pulse	E_{off}		334		μJ
Reverse Recovery Charge	Q_{rr}		480		nC

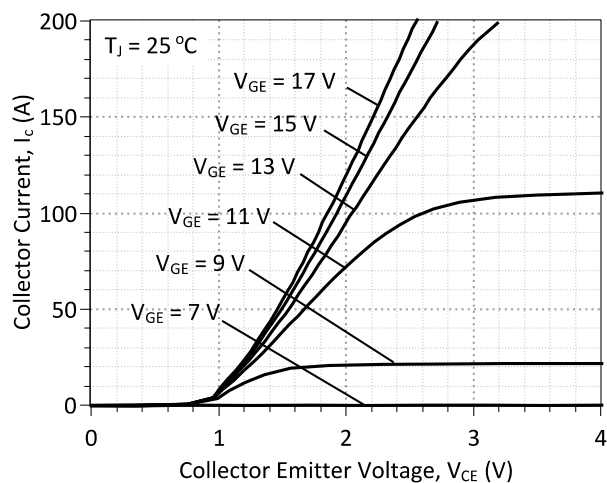


Figure 1: Typical Output Characteristics at 25 °C

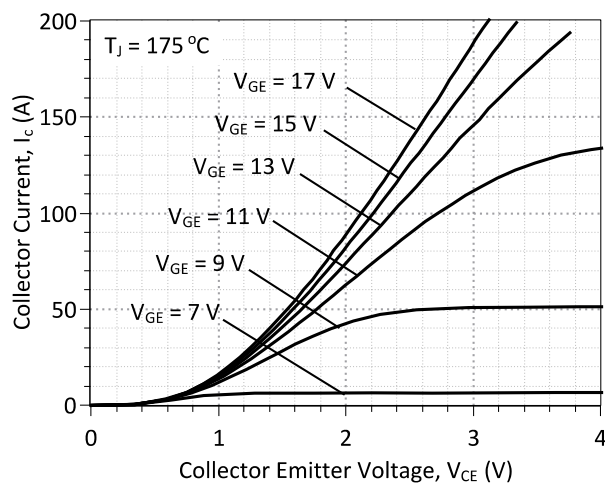


Figure 2: Typical Output Characteristics at 175 °C

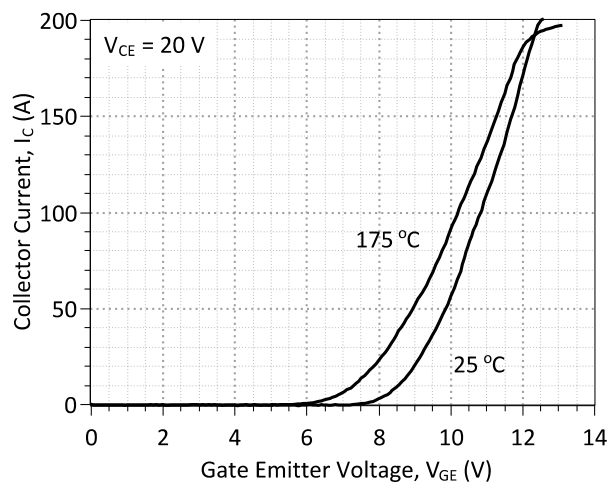


Figure 3: Typical Transfer Characteristics

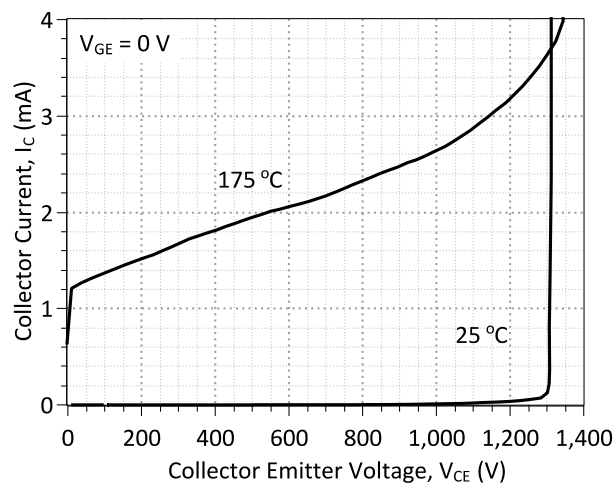


Figure 4: Typical Blocking Characteristics

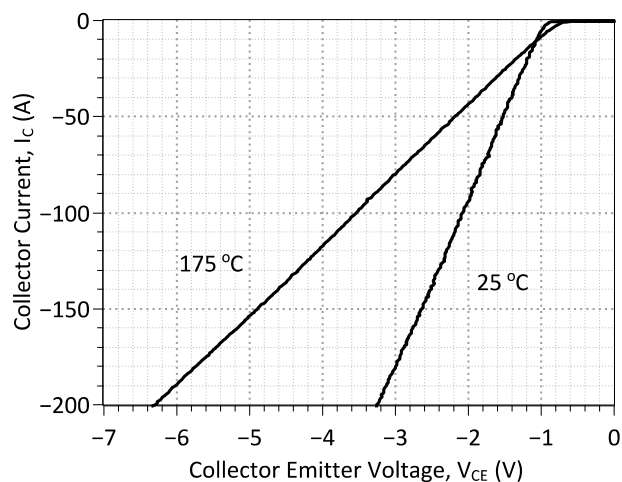


Figure 5: Typical FWD Forward Characteristics

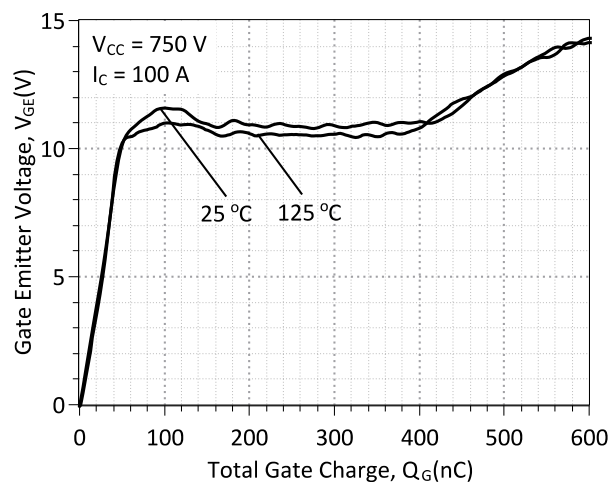


Figure 6: Typical Turn On Gate Charge

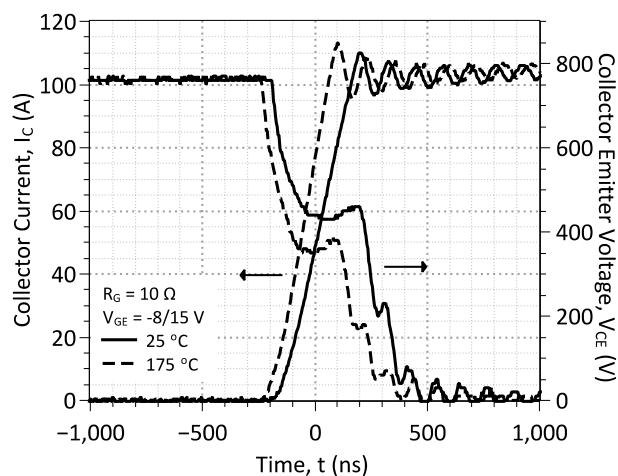


Figure 7: Typical Hard-Switched IGBT Turn On Waveforms

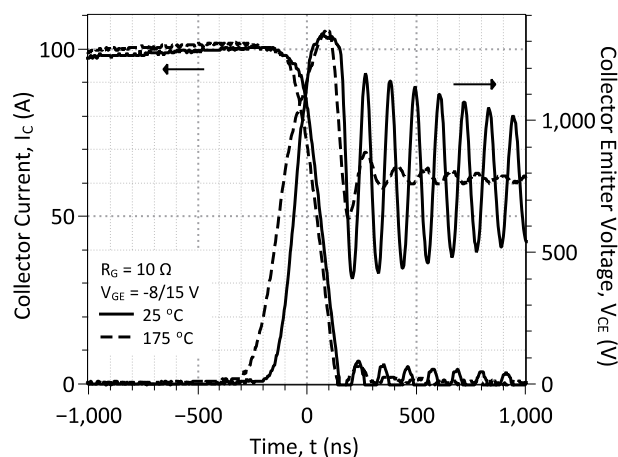


Figure 8: Typical Hard-Switched IGBT Turn Off Waveforms

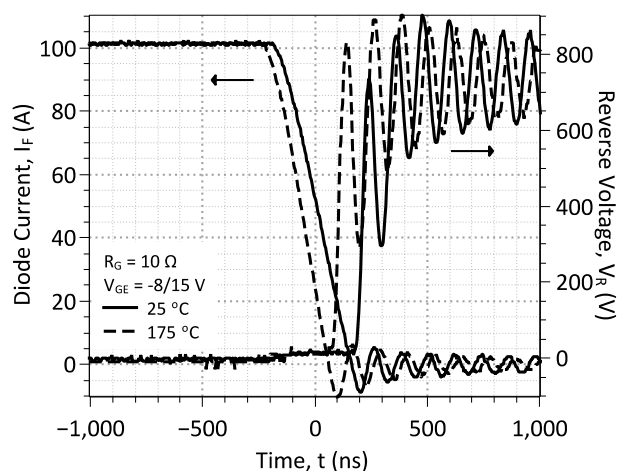


Figure 9: Typical Hard-Switched Free-wheeling SiC Diode Turn Off Waveforms

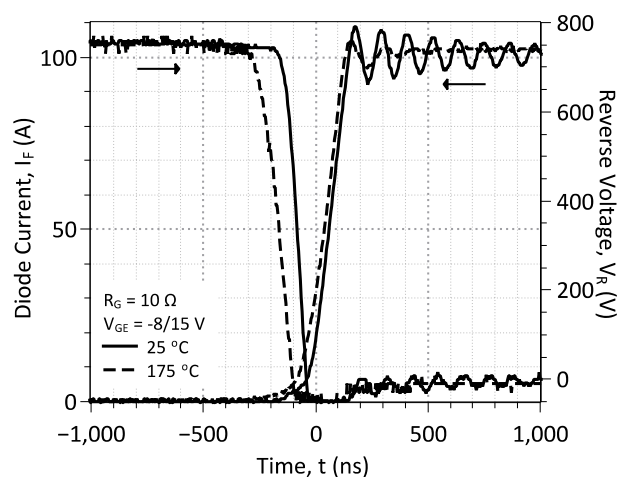


Figure 10: Typical Hard-Switched Free-wheeling SiC Diode Turn On Waveforms

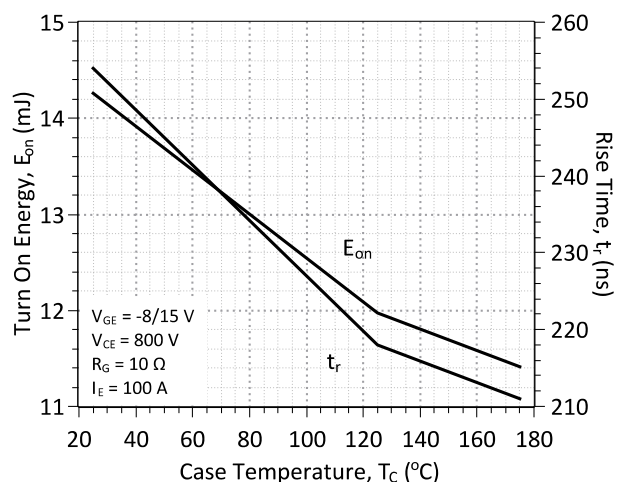


Figure 11: Typical Module Energy Losses and Switching Times at IGBT Turn On vs. Temperature

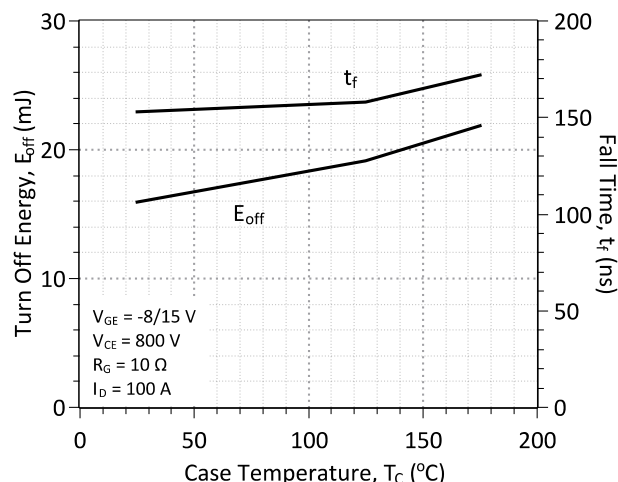


Figure 12: Typical Module Energy Losses and Switching Times at IGBT Turn Off vs. Temperature

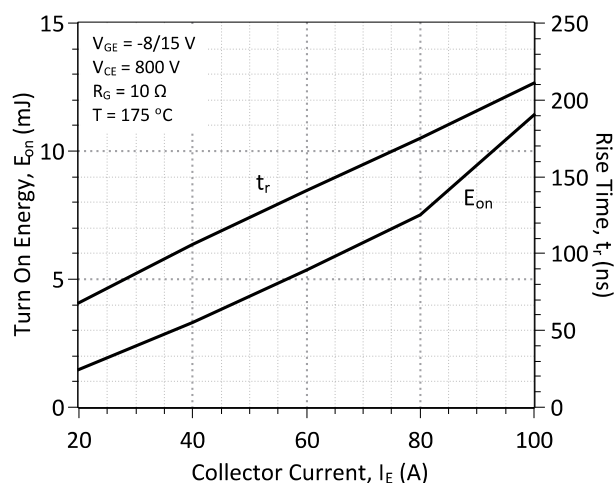


Figure 13: Typical Module Energy Losses and Switching Times at IGBT Turn On vs. Current

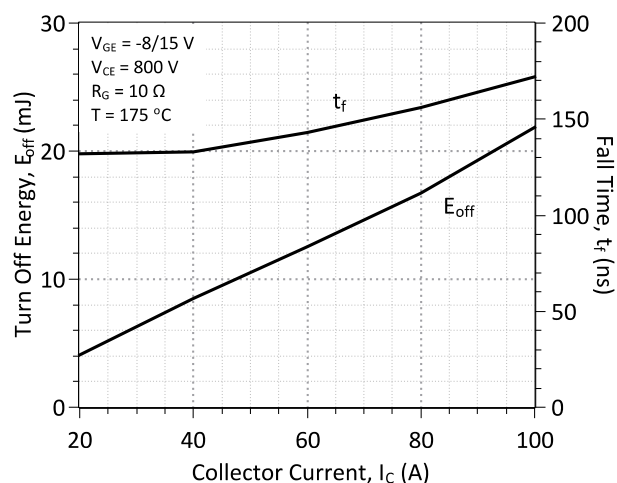


Figure 14: Typical Module Energy Losses and Switching Times at IGBT Turn Off vs. Current

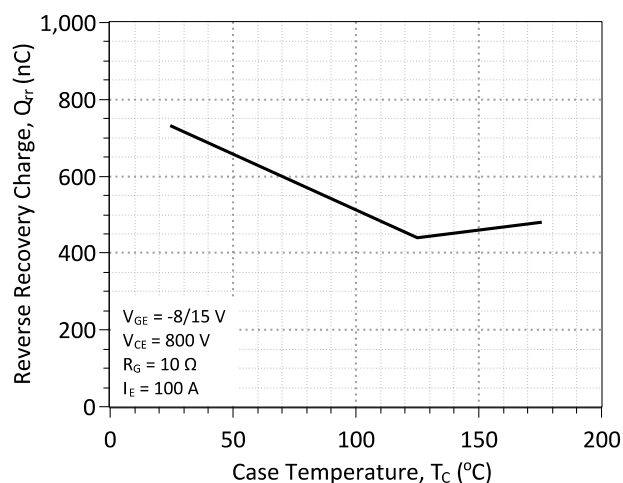


Figure 15: Typical Hard-Switched Reverse Recovery Charge vs. Temperature

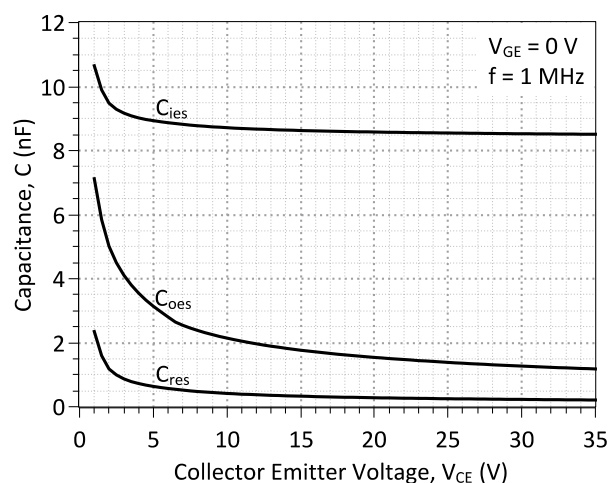
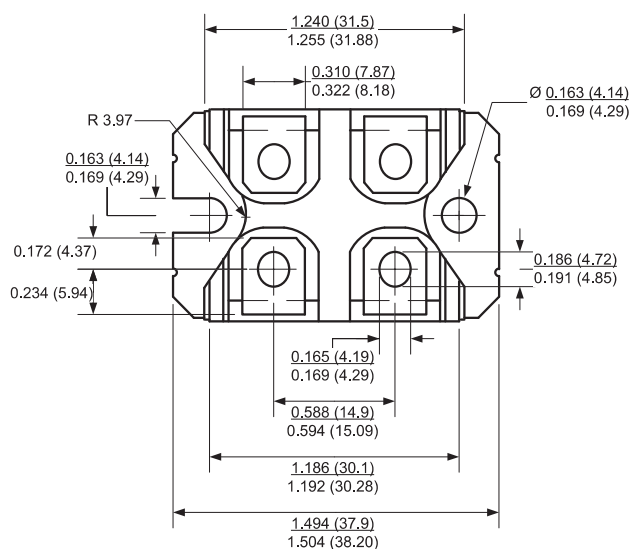


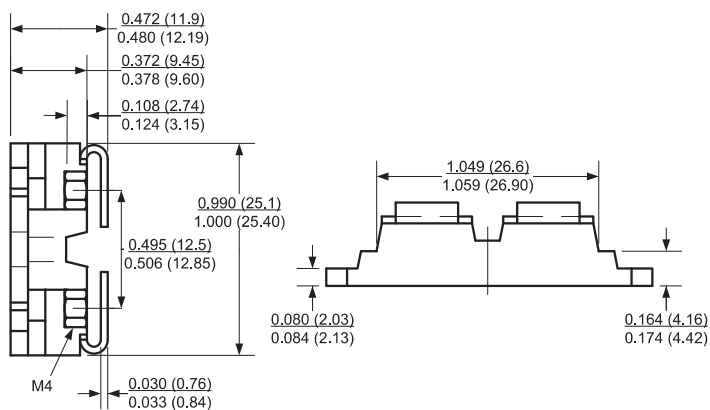
Figure 16: Typical C-V Characteristics

Package Dimensions:

SOT-227



PACKAGE OUTLINE



NOTE

- NOTE
1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History			
Date	Revision	Comments	Supersedes
2013/02/08	2	Updated Electrical Characteristics	
2012/07/30	1	Second generation release	GA100XCP12-227
2011/01/06	0	Initial release	

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